					Application/Control N 09/059,562	Applicant(s)/Patent Under R examination KONUMA ET AL.			
		Notice of Refere	ences Vited		Examiner		Art Unit		
								Page 1 of 1	
Dung Nguyen 2871 U.S. PATENT DOCUMENTS									
*		DOCUMENT NO.	DATE	NAME CLASS		CLASS	SUBCLASS	DOCUMENT SOURCE ** APS OTHER	
	A	4775225	Oct. 1988	Tsuboyama	a et al.	349	124	D D	OTHER
	В	4796979	Jan. 1989	Tsuboyama 35		350	350		
	С	5221980	Jun. 1993	Yamamoto		349	42		
	D	5408	Apr. 1995	Inaba et al.		345	89		
	Ε								
	F								
	G								
	н								
	-								
	J								
	κ								
	L								
	М								
		FOREIGN PATENT DOCUMENTS						DOCUMENT	
*		DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUBCLASS	SOURCE ** APS OTHER	
	z								
	0								
	P								
	Q.								
	R								
_	s								
	Т								
	لنا		1	NON-PA	TENT DOCUMENTS	L		i	
*		DO		DOCUMENT SOURCE **					
			DOCUMENT (Including Author, Title Date, Source, and Pertinent Pages)						OTHER
	U								
	٧								
	w								0
	х								

*A copy of this reference is not being furnished with this Office action. (See Manual of Patent Examining Procedure, Section 707.05(a).)
**APS encompasses any electronic search i.e. text, image, and Commercial Databases.
U.S. Patent and Trademark Office
PTO-892 (Rev. 03-98)

Notice of References Cited